


<b>Search Notes</b>  	<b>Application/Control No.</b>  10613502	<b>Applicant(s)/Patent Under Reexamination</b>  BEANE ET AL.
	<b>Examiner</b>  Eric Blatt	<b>Art Unit</b>  3734

SEARCHED			
Class	Subclass	Date	Examiner
606	144, 146	3-13-2008	EDB

SEARCH NOTES		
Search Notes	Date	Examiner
See attached EAST search history	3-13-2008	EDB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--